

# TECHNICAL SPECIFICATION

# IEC TS 62396-1

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## Process management for avionics – Atmospheric radiation effects –

### Part 1: Accommodation of atmospheric radiation effects via single event effects within avionics electronic equipment

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## CONTENTS

FOREWORD.....	4
INTRODUCTION.....	6
1 Scope and object.....	7
2 Normative references .....	7
3 Terms and definitions .....	7
4 Abbreviations used in the document .....	14
5 Radiation environment of the atmosphere.....	15
5.1 Radiation generation .....	15
5.2 Effect of secondary particles on avionics.....	16
5.3 Atmospheric neutrons.....	16
5.4 Secondary protons .....	21
5.5 Other particles.....	21
5.6 Solar enhancements.....	22
6 Effects of atmospheric radiation on avionics .....	22
6.1 Types of radiation effects .....	22
6.2 Single event effects.....	23
6.3 Total Ionising Dose (TID) .....	26
6.4 Displacement damage .....	27
7 Guidance for system designs.....	27
7.1 Overview .....	27
7.2 System design.....	30
7.3 Hardware considerations .....	31
7.4 Parts characterisation and control .....	32
8 Determination of avionics single event effects rates .....	34
8.1 Main single event effects.....	34
8.2 Single event effects with lower event rates .....	34
8.3 Single event effects with higher event rates - Single event upset data.....	36
8.4 Calculating SEE rates in avionics .....	42
9 Considerations for SEE compliance.....	42
9.1 Compliance .....	42
9.2 Confirm the radiation environment for the avionics application .....	42
9.3 Identify system development assurance level .....	42
9.4 Assess preliminary electronic equipment design for SEE.....	43
9.5 Verify that the system development assurance level requirements are met for SEE.....	43
9.6 Corrective actions .....	43
Annex A (informative) Thermal neutron assessment .....	44
Annex B (informative) Methods of calculating SEE rates in avionics electronics.....	45
Annex C (informative) Review of test facility availability.....	50
Annex D (informative) Tabular description of variation of atmospheric neutron flux with altitude and latitude .....	54

Figure 1 – Energy Spectrum of Atmospheric Neutrons at 40 000 Feet (12 160 m), latitude 45 degrees .....	17
Figure 2 – Variation of the Atmospheric Neutron Flux with Altitude (see Annex D) .....	18
Figure 3 – Distribution of vertical rigidity cut offs around the world.....	19
Figure 4 – Variation of the 1 to 10 MeV atmospheric neutron flux with latitude .....	20
Figure 5 – Energy Spectrum of Protons within the Atmosphere .....	21
Figure 6 – System Safety Assessment Process .....	28
Figure 7 – SEE in relation to System and LRU effect. ....	30
Figure 8 – Variation of RAM SEU cross section as function of neutron/proton energy .....	38
Figure 9 – Neutron and proton SEU bit cross-section data .....	39
Figure 10 – SEU cross section in SRAMs as function of manufacture date.....	40
Figure 11 – SEU cross section in DRAMs as function of manufacture date .....	41
Table 1 – Nomenclature Cross Reference .....	29
Table B.1 – Sources of high energy proton or neutron SEU cross section data .....	46
Table B.2 – Some Models for the Use of Heavy Ion SEE Data to Calculate Proton SEE Data.....	47
Table D.1 – Variation of 1 to 10 MeV neutron flux in the atmosphere with altitude.....	54
Table D.2 – Variation of 1 to 10 MeV neutron flux in the atmosphere with latitude.....	54

## INTERNATIONAL ELECTROTECHNICAL COMMISSION

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**PROCESS MANAGEMENT FOR AVIONICS –  
ATMOSPHERIC RADIATION EFFECTS –****Part 1: Accommodation of atmospheric radiation effects via  
single event effects within avionics electronic equipment**

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- the required support cannot be obtained for the publication of an International Standard, despite repeated efforts, or
- The subject is still under technical development or where, for any other reason, there is the future but no immediate possibility of an agreement on an International Standard.

Technical specifications are subject to review within three years of publication to decide whether they can be transformed into International Standards.

IEC 62396-1, which is a technical specification, has been prepared by IEC technical committee 107: Process management for avionics.

The text of this technical specification is based on the following documents:

Enquiry draft	Report on voting
107/41/DTS	107/46/RVC

Full information on the voting for the approval of this technical specification can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

IEC 62396, as currently conceived, consists of the following parts, under the general title *Process management for avionics – Atmospheric radiation effects*:

- Part 1: Accommodation of atmospheric radiation effects via single event effects within avionics electronic equipment
- Part 2: Guidelines for single event effects testing for avionics systems<sup>1</sup>
- Part 3: Guidelines to optimize avionics system design to reduce single event effects rates<sup>1</sup>
- Part 4: Guidelines for designing with high voltage aircraft electronics and potential single event effects<sup>1</sup>
- Part 5: Guidelines for assessing thermal neutron fluxes and effects in avionics systems<sup>1</sup>

The committee has decided that the contents of this publication will remain unchanged until the maintenance result date indicated on the IEC web site under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- transformed into an International standard,
- reconfirmed;
- withdrawn;
- replaced by a revised edition, or
- amended.

A bilingual version of this publication may be issued at a later date.

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<sup>1</sup> Under consideration.

## INTRODUCTION

This industry-wide technical specification informs avionics systems designers, electronic equipment, component manufacturers and their customers of the kind of ionising radiation environment that their devices will be subjected to in aircraft, the potential effects this radiation environment can have on those devices, and some general approaches for dealing with these effects.

The same atmospheric radiation (neutrons) that is responsible for the radiation exposure that crew and passengers acquire while flying is also responsible for causing the Single Event Effects (SEE) in the avionics electronic equipment. There has been much work carried out over the last few years related to the radiation exposure of aircraft passengers and crew. A standardised industry approach on the effect of the atmospheric neutrons on electronics should be viewed as consistent with and an extension of the on-going activities related to the radiation exposure of aircraft passengers and crew.

Atmospheric radiation effects are one factor that could contribute to equipment hard and soft fault rates. From a system safety perspective, using derived fault rate values, the existing methodology described in ARP4754 (accommodation of hard and soft fault rates in general) will also accommodate atmospheric radiation effect rates.

In addition, this technical specification is related to the JEDEC Standard JESD89, which relates to soft errors in electronics by atmospheric radiation at ground level (at altitudes less than 10 000 feet (3 040 m)).

## **PROCESS MANAGEMENT FOR AVIONICS – ATMOSPHERIC RADIATION EFFECTS –**

### **Part 1: Accommodation of atmospheric radiation effects via single event effects within avionics electronic equipment**

#### **1 Scope and object**

This Technical Specification is intended to provide guidance on Atmospheric Radiation effects on Avionics electronics used in aircraft operating at altitudes up to 60 000 feet (18,3 km). It defines the radiation environment, the effects of that environment on electronics and provides design considerations for the accommodation of those effects within avionics systems.

This Technical Specification is intended to help aerospace equipment manufacturers and designers to standardise their approach to Single Event Effects in Avionics by providing guidance, leading to a standard methodology.

Details of the radiation environment are provided together with identification of potential problems caused as a result of the atmospheric radiation received. Appropriate methods are given for quantifying Single Event Effect (SEE) rates in electronic components. The overall system safety methodology should be expanded to accommodate the Single Event Effects rates and to demonstrate the suitability of the electronics for the application at the component and system level.

#### **2 Normative references**

The following referenced documents are indispensable for the application of this document. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 62239, *Process management for avionics – Preparation of an electronic components management plan*